Dynamic Reliability Evaluation for a Multi-State Component Under Stress-Strength Model

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Abstract: For many technical systems, stress-strength models are of special importance. Stress-strength models can be described as an assessment of the reliability of the component in terms of *X* and *Y* random variables where *X* is the random "stress" experienced by the component and *Y* is the random "strength" of the component available to overcome the stress. The reliability of the component is the probability that component is strong enough to overcome the stress applied on it. Traditionally, both the strength of the component and the applied stress are considered to be both time-independent random variables. But in most of real life systems, the status of a stress and strength random variables clearly change dynamically with time. Also, in many important systems, it is very necessary to estimate the reliability of the component is subjected to two stresses. In particular, inspired by the idea of Kullback-Leibler divergence, we aim to propose a new method to compute the dynamic reliability of the component strength is equal to applied stress. In addition, the formed function can include both stresses when two stresses exist at the same time. Also, the proposed method provides a simple way and good alternative to compute the reliability of the component in case of at least one of the stress or strengths quantities depend on time.

Keywords: Kullback-Leibler divergence; dynamic reliability; stress-strength model; multi-state component; gamma distribution.

1. Introduction

The reliability of technical systems is one of the most important research subjects in the point reached by modern science. In some cases, the performance rate of the system depends variable environmental conditions which cause degradation. The system may not fail fully, but can degrade and there may exist several operation level of the system. A system that can have a finite number of operation levels is called a multi-state system. Generally, multi-state system is consisted of components that they also can be multi-state. The operation levels of the components can range from perfect functioning up to complete failure. The quality of the system is completely determined by components. Because, components failure can lead to the degradation of the entire multi-state system performance. Multi-state systems offer a flexible structure for modeling engineering systems.

In literature, much attention has been paid to multi-state system modeling. Hudson and Kapur [1] presented some models and their applications, in terms of reliability evaluation, to situations where the system and all its components have a multiple state. Ebrahimi [2] proposed two types of multi-state system and presented various properties related to them. Brunella and Kapur [3] studied a series of reliability measures and expanded their definitions to be consisted with binary, multi-state and continuum models. Kuo and Zuo [4] focused on multi-state system reliability models and introduced several special multi-state system reliability models. Eryılmaz [5] studied mean residual and mean past lifetime concepts for multi-state systems. Gökdere and Gürcan [6] designed a system which consists of two components that can be repairable with the aging property. Firstly, the Laplace-Stieltjes transform of the system is formed. Later, the mean operating time of the system is calculated by means of Laplace-Stieltjes transform, Also, for more details about multi-state system model one can see Lisnionski and Levitin [7].

Stress-strength models are very important for reliability analysis and have a wide application area in engineering applications. In the simplest terms, stress-strength model can be described as an assessment of the reliability of the component in terms of X and Y random variables where X is the random "stress" experience by the component and Y is the random "strength" of the component available to overcome the stress.

From this simplified explanation, the reliability of the component is the probability that the component is strong enough to overcome the stress apply on it. Then the reliability of the system is defined as

$$R = P(X < Y) = \int_{0}^{\infty} F(x) dG(x), \qquad (1)$$

where F(x) and G(x) are distribution functions of X and Y, respectively. In literature, extensive works have been done about stress-strength reliability. Chandra and Owen [8] studied the estimation of the reliability of a component where component is subject to several stresses whereas its strength is a single random variable. Eryılmaz and İşçioğlu [9], Gökdere and Gürcan [10,11] studied multi-state systems in a stress-strength setup. Also, for comprehensive information about all methods and results on the stress-strength model one can see Kotz et al. [12].

In this paper, we suppose that the component is subject to X_1 and X_2 stresses, which remain fixed over time, whereas its strength, Y(t), is a single random variable, which is stochastically decreasing in time. Let, X_2 is stochastically larger than X_1 , i.e., for real α , $P(X_2 > \alpha) \ge P(X_1 > \alpha)$. The failure of the component occurs when the firstly time-independent X_1 stress process and then X_2 stress process exceed the time-dependent strength. The use of multiple stresses rather than single stress is more realistic approach in the reliability of technical systems.

The rest of the paper is organized as four sections. Section 2 contains some information about Kullback-Leibler divergence. In section 3, we explain the proposed approach for evaluation of the component's dynamic operational level under stress-strength setup. Section 4 gives a Gamma distributed example to illustrate the theoretical results for the proposed approach. In section 5, we summarize what we have done in the paper.

2. Materials and Methods

The Kullback-Leibler divergence which introduced by Kullback and Leibler [13], gives an asymmetric measure of the similarity between the distributions of two random variables. If the densities p(x) and q(x) of P and Q, respectively, exist with respect to Lebesque measure, the Kullback-Leibler divergence $D_{KL}(P \parallel Q)$ of Q from P is defined as

$$D_{KL}(P \parallel Q) = \int_{S} p(x) \log \frac{p(x)}{q(x)} dx, \qquad (2)$$

where S is the support set of p(x). Note that, $D_{KL}(P \parallel Q)$ is finite only if P is absolutely continuous with respect to Q, and $+\infty$ otherwise. Also, the Kullback-Leibler divergence remains non-negative and is zero if and only if P = Q. It is important to point that the Kullback-Leibler divergence is not a symmetrical quantity.

In information theory and machine learning, the Kullback-Leibler divergence plays an important role. In literature, much attention has been paid to it. Dahlhaus [14] calculated the asymptotic Kulback-Leibler information divergence of two locally stationary sequences and the limit of the Fisher information matrix. Do [15] proposed a fast algorithm to approximate the Kullback-Leibler distance between two hidden Markov models. Rached et al. [16] provided an explicit computable expression for the Kullback-Leibler divergence rate between two arbitrary time-invariant finite-alphabet Markov sources. Lee and Park [17] considered estimation of the Kullback-Leibler divergence between the true density and a selected parametric model.

3. Operation Performance of the Component

In this section, we use Kullback-Leibler divergence for computing the component operation level where component is subject to X_1 and X_2 stresses with continuous cumulative distribution function $F_l(x) = P\{X_l \le x\}$ (l = 1, 2), whereas its strength, Y(t), is a single random variable with marginal distribution function $G_t(x) = P\{Y(t) \le x\}$.

In our method, we first set Kullback-Leibler divergence $D_{KL(l)}^{(t)} = D_{KL}(Y(t) \parallel X_l)$ of X_l from Y(t) by using (2) for l = 1, 2. After setting Kullback-Leibler divergence, we calculate the $D_{KL(l)}^{(t)}$ for selected values of the parameters of marginal lifetime distributions of the stress and strength random variables. Then using these values, the operation level of the component depending on the both stresses can be defined as follows

The operation level of the component =
$$\begin{cases} 2, & t < t_2 \\ 1, & t_2 \le t < t_1 \\ 0, & t_1 \le t \end{cases}$$

where t_l (l = 1, 2) denotes the time when $D_{KL(l)}^{(t)}$ is equal to zero. Also using $D_{KL(l)}^{(t)}$ and t_l values we can define the following equations

$$\zeta_t^1 = \begin{cases} D_{KL(1)}^{(t)}, & t_2 \le t < t_1 \\ 0, & t < t_2 \end{cases}$$

and

$$\zeta_t^2 = \begin{cases} D_{KL(2)}^{(t)}, & t < t_2 \\ 0, & t_2 \le t < t_1 \end{cases}$$

Now with the help of the above equalities, the reliability degree Rd(t) of the component depending on its operation level can be expressed as follows:

$$Rd(t) = (1 - \alpha_t) \frac{\zeta_t^1}{u_1} + \alpha_t \left(1 + \frac{\zeta_t^2}{u_2} \right),$$
(3)

,

where

$$\alpha_t = \begin{cases} 1, & \zeta_t^2 > 0\\ 0, & \zeta_t^2 = 0 \end{cases}$$

and $u_l = \sup D_{KL(l)}^{(t)}$. The superiority of the Rd(t) which is presented in (3) is that when two stresses exist at the same time the formed function can include both stresses at the same time. However, when R which is presented in (1) is used, this is not possible because of stresses are evaluated separately. In probabilistic design it is common to use parametric statistical models to compute the reliability obtained from stress-strength interference theory. In the following section we apply our method to a gamma distributional example.

4. Gamma Distributional Example

A gamma process is frequently used for lifetime analysis and reliability testing. Let us suppose that Y(t) is gamma random variables with cumulative distribution function

$$G_t(x; k, \theta(t)) = \gamma\left(k, \frac{x}{\theta(t)}\right) \frac{1}{\Gamma(k)}, \qquad (4)$$

where $\gamma\left(k, \frac{x}{\theta(t)}\right)$ is the lower incomplete gamma function, k > 0 is the shape parameter and $\theta(t)$ is the scale parameter which decreases over time.

Similarly, assume that X_1 and X_2 stresses are gamma random variables with cumulative distribution functions

$$F_l(x; k_l, \theta_l) = \gamma \left(k_l, \frac{x}{\theta_l} \right) \frac{1}{\Gamma(k_l)}, \qquad (5)$$

where $\gamma\left(k_{l}, \frac{x}{\theta_{l}}\right)$ is the lower incomplete gamma function, $\Gamma(k_{l})$ is the gamma function, $k_{l} > 0$ is the shape parameter, θ_{l} is the scale parameter and l = 1, 2. Also both k_{l} and θ_{l} are constant with aging time.

For obtaining the reliability degree $\mathbf{Rd}(t)$ of the component, at first we derive a closed form solution for the Kullback-Leibler divergence $D_{KL(l)}^{(t)}$ for l = 1, 2. Using probability density functions of (4) and (5) in (2) and referring to Bauckhage [18], the $D_{KL(l)}^{(t)}$ can be obtained as

$$D_{KL(l)}^{(t)} = \int_{0}^{\infty} \frac{x^{k-1}}{\left(\theta(t)\right)^{k} \Gamma(k)} \exp\left(-\frac{x}{\theta(t)}\right) \ln \frac{\frac{x^{k-1}}{\left(\theta(t)\right)^{k} \Gamma(k)} \exp\left(-\frac{x}{\theta(t)}\right)}{\frac{x^{k_{l}-1}}{\left(\theta_{l}\right)^{k_{l}} \Gamma(k_{l})} \exp\left(-\frac{x}{\theta_{l}}\right)}$$

$$=\ln\frac{(\theta_l)^{k_l}\Gamma(k_l)}{(\theta(t))^k\Gamma(k)}+\frac{k-k_l}{(\theta(t))^k\Gamma(k)}\int_0^\infty x^{k-1}\exp\left(-\frac{x}{\theta(t)}\right)\ln x dx+\frac{\frac{1}{\theta_l}-\frac{1}{\theta(t)}}{(\theta(t))^k\Gamma(k)}\int_0^\infty x^k\exp\left(-\frac{x}{\theta(t)}\right) dx.$$

By making the substitution $t = \frac{x}{\theta(t)}$ in above equation and then using following integrals,

$$\int_{0}^{\infty} x^{\nu-1} \exp(-\mu x) \ln x dx = \frac{1}{\mu^{\nu}} \Gamma(\nu) [\psi(\nu) - \ln \mu],$$

where $\psi(v) = \frac{d}{dv} \ln \Gamma(v)$ is the psi function (Eq. 4.352.1 in Gradshteyn and Ryzhik, [19]) and

$$\int_{0}^{\infty} x^{\nu-1} \exp(-\mu x) dx = \frac{1}{\mu^{\nu}} \Gamma(\nu),$$

where $\mu > 0$ and $\nu > 0$ (Eq. 3.381.4 in Gradshteyn and Ryzhik, [19]) we have

$$D_{KL(l)}^{(t)} = \ln \frac{(\theta_l)^{k_l} \Gamma(k_l)}{\left(\theta(t)\right)^k \Gamma(k)} + (k - k_l) \left(\ln \theta(t) + \psi(k)\right) + k \left(\frac{\theta(t)}{\theta_l} - 1\right).$$
(6)

Because of $\theta(t)$ decreases over time, in (6), let $\theta(t) = 1/t$ then we finally have

$$D_{KL(l)}^{(t)} = \ln \frac{(t)^k (\theta_l)^{k_l} \Gamma(k_l)}{\Gamma(k)} + (k - k_l) \left(\ln \frac{1}{t} + \psi(k) \right) + k \left(\frac{1}{t\theta_l} - 1 \right), \tag{7}$$

where l = 1, 2. In order to compare Rd(t) and R expediently, let $k = k_1 = k_2 = 1$ in (7) then we can get

$$D_{KL(l)}^{(t)} = \ln(t\theta_l) + \frac{1}{t\theta_l} - 1,$$
(8)

Also, taking into account that $\mathbf{k} = \mathbf{k}_1 = \mathbf{k}_2 = \mathbf{1}$ and $\boldsymbol{\theta}(t) = \mathbf{1}/t$, using (4) and (5) in (1) the reliability function can be easily derived as

$$R_l(t) = P(X_l < Y(t)) = \frac{1}{1 + t\theta_l}.$$
(9)

For more details, see Chiodo et al. [20], Chiodo and Mazzanti [21] and Eryılmaz [22].

Clearly, using (7) and (9) for t = 0, 1, 0, 2, ..., 2 and selected values of the parameters θ_1 and θ_2 we can obtain $D_{KL(l)}^{(t)}$ and $R_l(t)$ values presented in Table 1.

t	$D_{KL(1)}^{(t)}$	$D_{KL(2)}^{(t)}$	$R_1(t)$	$R_2(t)$
0.1	12.8533	8.9742	0.9433	0.9259
0.2	5.2130	3.4174	0.8928	0.8620
0.3	2.8407	1.7395	0.8474	0.8064
0.4	1.7395	0.9855	0.8064	0.7575
0.5	1.1293	0.5837	0.7692	0.7142
0.6	0.7561	0.3493	0.7352	0.6756
0.7	0.5134	0.2058	0.7042	0.6410
0.8	0.3493	0.1162	0.6756	0.6097
0.9	0.2356	0.0603	0.6493	0.5813
1.0	0.1558	0.0268	0.6250	0.5555
1.1	0.0996	0.0085	0.6024	0.5319
1.2	0.0603	0.0008	0.5813	0.5102
t_2	0.0456	0.	0.5714	0.5
1.3	0.0335	0.0007	0.5617	0.4901
1.4	0.0161	0.0061	0.5434	0.4716
1.5	0.0057	0.0156	0.5263	0.4545
1.6	0.0008	0.0281	0.5102	0.4385
t_1	0.	0.0366	0.5	0.4295
1.7	0.0001	0.0427	0.4950	0.4237
1.8	0.0028	0.0590	0.4807	0.4098
1.9	0.0082	0.0766	0.4672	0.3968
2.0	0.0156	0.0950	0.4545	0.3846

Table 1. Numerical values obtained from Equation (7) and (9) for $\theta_1 = 0.6$ and $\theta_2 = 0.8$

In Table1, $t_1 = 1.66$ and $t_2 = 1.25$. Also, it can be observed from numerical values in $D_{KL(1)}^{(t)}$ and $D_{KL(2)}^{(t)}$ columns how stresses affect the performance of the component that operates under different parameters. When the component starts working, its strength is greater than either stresses. However, because the component's strength is decreasing depending on the selected time, as the uptime increases at first the Kullback-Leibler divergence $D_{KL(2)}^{(t)}$ decreases to near zero. In this period, the strength of the component will begin to move to the average position declined from a good position. From the moment that $D_{KL(2)}^{(t)} = 0$, the component will pass to the average working period from a good working period, the Kullback-Leibler divergence $D_{KL(2)}^{(t)}$ is not considered and instead of the Kullback-Leibler divergence $D_{KL(1)}^{(t)}$ will be reduced again depending on the time. From the moment it is equal to zero, the operation of the machine will end and because the machine's durability remains weak in both stresses the machine will be impaired. In the table, there are also separately calculated $R_1(t)$ and $R_2(t)$ reliabilities of the machine according to either stresses.

When attention is paid to their numerical values, for the stress and strength have the same parameters the reliability values becomes 0.5. This numeric value does not provide clear information about the component's operating performance. Considering two stresses, a joint reliability is not calculated but instead the reliability is calculated separately according to the stresses.

In Figure 1 and 2, we plot the reliability score $R_1(t)$ and $R_2(t)$ at time t for $\theta_1 = 0.6$ and $\theta_2 = 0.8$, respectively. In Figure 3, we plot the reliability degree Rd(t) of the component at time t for $\theta_1 = 0.6$ and $\theta_2 = 0.8$.



Figure 1. Reliability for $R_1(t)$ at time t



Figure 2. Reliability for $R_2(t)$ at time t



Figure 3. Reliability degree Rd(t) at time t

Finally, using (3) for ζ_t^1 and ζ_t^2 values in Table 1, $u_1 = 12.8533$ and $u_2 = 8.9742$, we can obtain dynamic reliability degree presented Table 2 for the component under stress-strength setup.

t	Rd(t)	t	Rd (<i>t</i>)
0.1	2.	1.2	1.00008
0.2	1.3808	1.25	1.
0.3	1.1938	1.3	0.0026
0.4	1.1098	1.4	0.0012
0.5	1.0650	1.5	0.0004
0.6	1.0389	1.6	0.000006
0.7	1.0229	1.66	0.
0.8	1.0129	1.7	0.
0.9	1.0067	1.8	0.
1.0	1.0029	1.9	0.
1.1	1.0009	2.0	0.

Table 2. Dynamic reliability degree for the component when $\theta_1 = 0.6$ and $\theta_2 = 0.8$

5. Conclusions

In this study, we aimed to measure the damage caused by stresses which applied to the component. In the method that we have offered, it is preferred to use Kullback-Leibler divergence to obtain this measurement. Because Kullback-Leibler divergence plays an important role in information theory and statistics. The Kullback-Leibler divergence is not a metric. But this feature does not adversely affect the use of our method. Also it is assumed that the Kullback-Leibler divergence is known. In our method, it is theoretically assumed that a component operates under two different stresses and when the component's strength remains weak in both stresses the component fails. Let us consider two stresses by using (1), a joint reliability is not calculated. However, instead the reliability can be calculated separately according to the stresses. Here, for reliability evaluation we provide a new approach for obtaining the component operation performance. The proposed method can clearly show the change of component operation performance under two stresses depending on time. When the related parameters of the component in Table 2 are selected as $\theta_1 = 0.6$ and $\theta_2 = 0.8$, the values of reliability distribution. When different effect functions are used instead of probability functions of stress and strength, the recommended method can be easily used.

Conflicts of Interest: The authors declare no conflict of interest.

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